



BSI Standards Publication

Semiconductor devices - Mechanical and climatic test methods

Part 9: Permanence of marking (IEC 60749-9:2017)

National foreword

This British Standard is the UK implementation of EN 60749-9:2017. It is identical to IEC 60749-9:2017. It supersedes BS EN 60749-9:2002, which is withdrawn.

The UK participation in its preparation was entrusted to Technical Committee EPL/47, Semiconductors.

A list of organizations represented on this committee can be obtained on request to its secretary.

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Published by BSI Standards Limited 2017

ISBN 978 0 580 94935 7

ICS 31.080.01

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This British Standard was published under the authority of the Standards Policy and Strategy Committee on 30 November 2017.

Amendments/corrigenda issued since publication

Date	Text affected
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